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AON7458 250V,5A N-Channel MOSFET

General Description

The AON7458 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low $R_{\mathrm{DS}(on)},\,C_{\mathrm{iss}}$ and C_{rss} along with guaranteed avalanche capability this device can be adopted quickly into new and existing offline power supply designs.This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

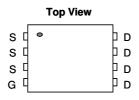
V_{DS} 300V@150℃

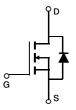
$$\begin{split} & I_{D} \; (\text{at V}_{\text{GS}} \! = \! 10\text{V}) & 5\text{A} \\ & R_{\text{DS(ON)}} \; (\text{at V}_{\text{GS}} \! = \! 10\text{V}) & < 0.56\Omega \end{split}$$

100% UIS Tested! 100% R_g Tested!









Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	250	V			
Gate-Source Voltage		V _{GS}	±30	V			
Continuous Drain	T _C =25℃		5				
Current ^B	T _C =100℃	I _D	3.2	A			
Pulsed Drain Current ^C		I _{DM}	16				
Continuous Drain	T _A =25℃		1.5	A			
Current	T _A =70℃	IDSM	1.2	A			
Avalanche Current ^C		I _{AR}	2.1	A			
Repetitive avalanche energy ^C		E _{AR}	66	mJ			
Single pulsed avalanche energy G		E _{AS}	132	mJ			
Peak diode recovery dv/dt		dv/dt	5	V/ns			
	T _C =25℃	P _D	33	W			
Power Dissipation ^B	T _C =100℃	I.D	13	W			
	T _A =25℃	D	3.1	w			
Power Dissipation ^A	T _A =70℃	P _{DSM}	2	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-50 to 150	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	30	40	€/M			
Maximum Junction-to-Ambient AD	Steady-State	ιιθЈΑ	60	75	€/M			
Maximum Junction-to-Case Steady		$R_{\theta JC}$	3.1	3.7	€\M			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V,\ T_J=25^{\circ}C$	250						
		$I_D=250\mu A,\ V_{GS}=0V,\ T_J=150^{\circ}C$		300		V			
BV _{DSS} /ΔTJ	Zero Gate Voltage Drain Current	ID=250μA, VGS=0V		0.25		V/°C			
/Δ10		V _{DS} =250V, V _{GS} =0V			1				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =200V, T _J =125℃			10	μΑ			
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±30V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	3.1	3.7	4.3	V			
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =1.5A		0.46	0.56	Ω			
g _{FS}	Forward Transconductance	V _{DS} =40V, I _D =1.5A		5		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.77	1	V			
Is	Maximum Body-Diode Continuous Current				5	Α			
I _{SM}	Maximum Body-Diode Pulsed Current				16	Α			
DYNAMIC	PARAMETERS		•						
C _{iss}	Input Capacitance		240	306	370	рF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =25V, f=1MHz	34	51	68	рF			
C _{rss}	Reverse Transfer Capacitance			3.2		рF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	1.7	3.4	5.1	Ω			
SWITCHING PARAMETERS									
Q_g	Total Gate Charge		4.8	6.0	7.2	nC			
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =200V, I _D =1.5A		2.0		nC			
Q_{gd}	Gate Drain Charge			1.5		nC			
t _{D(on)}	Turn-On DelayTime			14		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =125V, I_{D} =1.5A,		12		ns			
t _{D(off)}	Turn-Off DelayTime	$R_G=25\Omega$		23		ns			
t _f	Turn-Off Fall Time			12		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =1.5A,dI/dt=100A/μs,V _{DS} =100V	52	77	102	ns			
Q_{rr}	Body Diode Reverse Recovery Charge	_F I _F =1.5A,dI/dt=100A/μs,V _{DS} =100V	0.2	0.29	0.40	μС			

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power Dissipation P_{DSM} is based on $R_{\theta,JA}$ t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation PD is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}$ C. Ratings are based on low frequency and duty cycles to keep initial $T_{J}=25^{\circ}$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

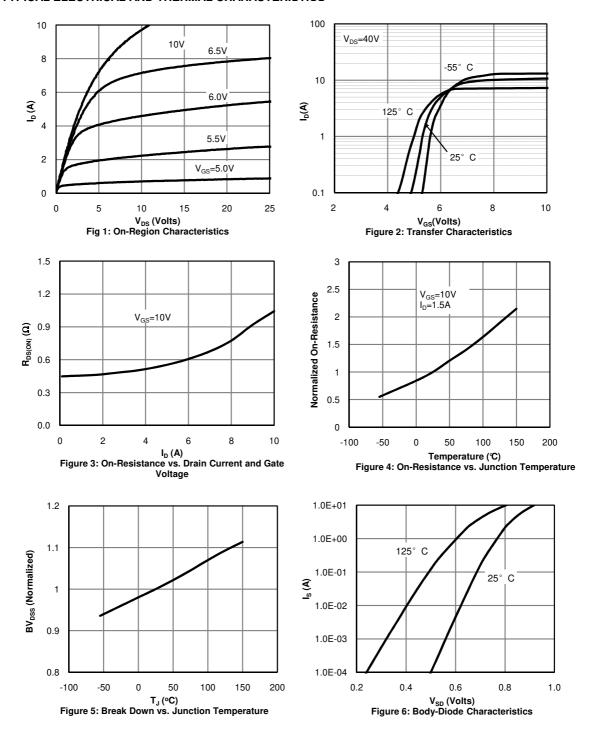
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G.These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.

H. L=60mH, $I_{AS}\!\!=\!\!2.1A,\,V_{DD}\!\!=\!150V,\,R_{G}\!\!=\!\!10\Omega,\,Starting\,\,T_{J}\!\!=\!\!25^{\circ}\,\,$ C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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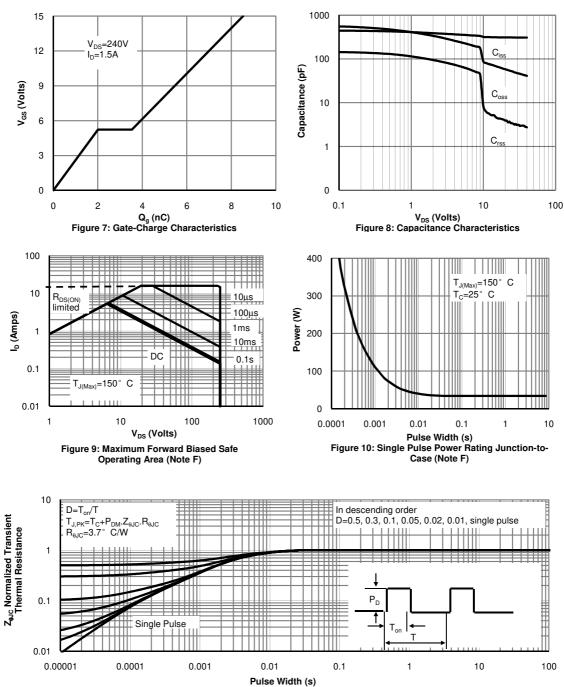
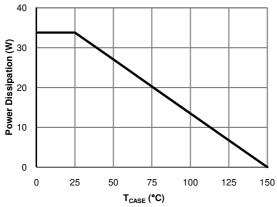


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



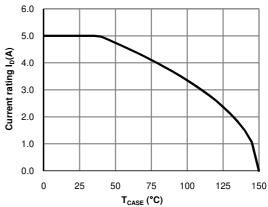
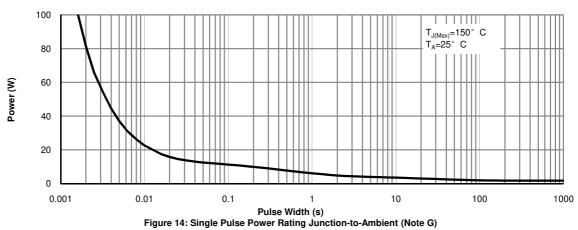
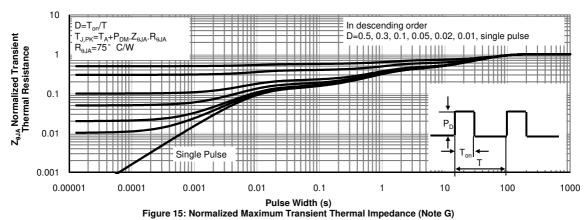


Figure 12: Power De-rating (Note B)

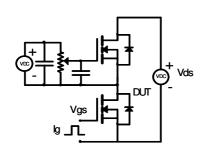
Figure 13: Current De-rating (Note B)

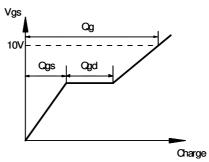




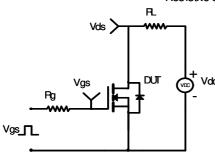


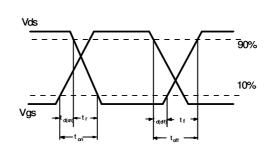
Gate Charge Test Circuit & Waveform



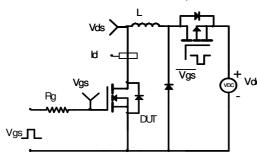


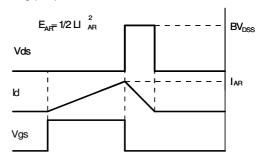
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

